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APPLICANTS Steve Biellak, Sunnyvale, CA; Stanley E. Stokowski, Danville, CA; Mehdi Vaez-Iravani, Los Gatos, CA;				
** CONTINUING DATA ***** THIS APPLICATION IS A CIP OF 09/746,141 12/21/2000 WHICH IS A CON OF 08/933,771 09/19/1997 PAT 6,201,601				
** FOREIGN APPLICATIONS *****				
IF REQUIRED, FOREIGN FILING LICENSE GRANTED ** 08/17/2001				
Foreign Priority claimed <input type="checkbox"/> yes <input checked="" type="checkbox"/> no 35 USC 119 (a-d) conditions met <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance Verified and Acknowledged <u> </u> Examiner's Signature Initials		STATE OR COUNTRY CA	SHEETS DRAWING 3	TOTAL CLAIMS 45
INDEPENDENT CLAIMS 4				
ADDRESS Rahul Engineer SKJERVEN MORRILL MacPHERSON LLP 3 Embarcadero Center, Suite 2800 San Francisco, CA 94111				
TITLE Systems and methods for a wafer inspection system using multiple angles and multiple wavelength illumination				
FILING FEE RECEIVED 1240	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	